Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,204	CHO, DAE-HUN
Examiner	Art Unit
Craig Price	3754

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Class	Subclass	Date	Examiner
137	538 540 535	8/4/2005	СР
123	41.35	8/4/2005	СР
267	288	8/4/2005	CP

INTERFERENCE SEARCHED					
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(INCLUDING SEARCH	T	<i>).</i>
	DATE	EXMR
East and text search, including inventor's name search. Search from J. Rivell.	8/4/2005	СР
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